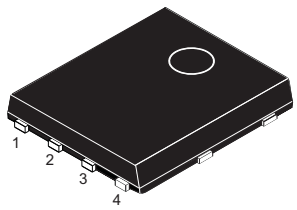
STL12N65M5

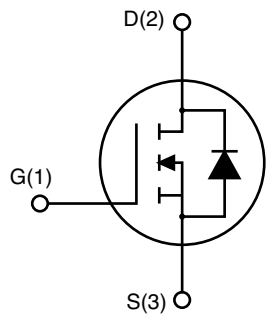
N-channel 650 V, 0.475 Ω typ., 8.5 A MDmesh™ V Power MOSFET in a PowerFLAT™ 5x6 HV package

Datasheet – production data



PowerFLAT™ 5x6 HV

Figure 1. Internal schematic diagram



AM01475v1

Features

Order code	V_{DSS}	$R_{DS(on)}$ max	I_D
STL12N65M5	710 V	0.530 Ω	8.5 A

- Outstanding $R_{DS(on)}$*area
- Extremely large avalanche performance
- Gate charge minimized
- Very low intrinsic capacitance
- 100% avalanche tested

Applications

- Switching applications

Description

This device is an N-channel MDmesh™ V Power MOSFET based on an innovative proprietary vertical process technology, which is combined with STMicroelectronics' well-known PowerMESH™ horizontal layout structure. The resulting product has extremely low on-resistance, which is unmatched among silicon-based Power MOSFETs, making it especially suitable for applications which require superior power density and outstanding efficiency.

Table 1. Device summary

Order code	Marking	Package	Packaging
STL12N65M5	12N65M5	PowerFLAT™ HV	Tape and reel

Contents

1 Electrical ratings

Table 2. Absolute maximum ratings

Symbol	Parameter	Value	Unit
V_{DS}	Drain-source voltage	650	V
V_{GS}	Gate-source voltage	± 25	V
I_D (1)	Drain current (continuous) at T_C = 25 °C	8.5	A
I_D (1)	Drain current (continuous) at T_C = 100 °C	4	A
I_{DM} (1),(2)	Drain current (pulsed)	34	A
P_{TOT} (1)	Total dissipation at T_C = 25 °C	48	W
I_{AR}	Avalanche current, repetitive or not-repetitive (pulse width limited by T_j max)	1.9	A
E_{AS}	Single pulse avalanche energy (starting T_j = 25 °C, $I_D = I_{AR}$, V_{DD} = 50 V)	130	mJ
dv/dt (3)	Peak diode recovery voltage slope	15	V/ns
T_{stg}	Storage temperature	- 55 to 150	°C
T_j	Max. operating junction temperature		°C

1. Limited by maximum junction temperature
2. Pulse width limited by safe operating area.
3. $I_{SD} \leq 8.5$ A, di/dt $\leq$ 400 A/μs, $V_{Peak} \leq V_{(BR)DSS}$, V_{DD} = 400 V.

Table 3. Thermal data

Symbol	Parameter	Value	Unit
$R_{thj\text{-}case}$	Thermal resistance junction-case max	2.6	°C/W
$R_{thj\text{-}pcb}$ (1)	Thermal resistance junction-pcb max	59	°C/W

1. When mounted on 1inch² FR-4 board, 2 oz Cu.

2 Electrical characteristics

(T_C = 25 °C unless otherwise specified)

Table 4. On /off states

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$V_{(BR)DSS}$	Drain-source breakdown voltage (V_{GS} = 0)	I_D = 1 mA	650			V
I_{DSS}	Zero gate voltage drain current (V_{GS} = 0)	V_{DS} = 650 V			1	µA
		V_{DS} = 650 V, T_C=125 °C			100	µA
I_{GSS}	Gate-body leakage current (V_{DS} = 0)	V_{GS} = ± 25 V			± 100	nA
$V_{GS(th)}$	Gate threshold voltage	V_{DS} = V_{GS}, I_D = 250 µA	3	4	5	V
$R_{DS(on)}$	Static drain-source on-resistance	V_{GS} = 10 V, I_D = 4.25 A		0.475	0.530	Ω

Table 5. Dynamic

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
C_{iss}	Input capacitance	V_{DS} = 100 V, f = 1 MHz, V_{GS} = 0	-	644	-	pF
C_{oss}	Output capacitance		-	18	-	pF
C_{rss}	Reverse transfer capacitance		-	2.5	-	pF
$C_{o(tr)}$(1)	Equivalent capacitance time related	V_{DS} = 0 to 520 V, V_{GS} = 0	-	55	-	pF
$C_{o(er)}$(2)	Equivalent capacitance energy related		-	17	-	pF
R_G	Intrinsic gate resistance	f = 1 MHz open drain	-	5	-	Ω
Q_g	Total gate charge	V_{DD} = 520 V, I_D = 4.5 A, V_{GS} = 10 V (see *Figure 16*)	-	17	-	nC
Q_{gs}	Gate-source charge		-	4.6	-	nC
Q_{gd}	Gate-drain charge		-	8.5	-	nC

1. $C_{oss\ eq.}$ time related is defined as a constant equivalent capacitance giving the same charging time as C_{oss} when V_{DS} increases from 0 to 80% V_{DSS}
2. $C_{oss\ eq.}$ energy related is defined as a constant equivalent capacitance giving the same stored energy as C_{oss} when V_{DS} increases from 0 to 80% V_{DSS}

Table 6. Switching times

Symbol	Parameter	Test conditions	Min.	Typ.	Max	Unit
$t_{d\ (v)}$	Voltage delay time	V_{DD} = 400 V, I_D = 6 A, R_G = 4.7 Ω, V_{GS} = 10 V (see *Figure 17*), (see *Figure 20*)	-	23	-	ns
$t_{r(v)}$	Voltage rise time		-	10	-	ns
$t_{f(i)}$	Current fall time		-	13.5	-	ns
$t_{c(off)}$	Crossing time		-	13	-	ns

Table 7. Source drain diode

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
I_{SD} (1)	Source-drain current		-		8.5	A
I_{SDM} (1),(2)	Source-drain current (pulsed)		-		34	A
V_{SD} (3)	Forward on voltage	I_{SD} = 8.5 A, V_{GS} = 0	-		1.5	V
t_{rr}	Reverse recovery time	I_{SD} = 8.5 A, di/dt = 100 A/µs V_{DD} = 60 V (see *Figure 17*)	-	232		ns
Q_{rr}	Reverse recovery charge		-	2		µC
I_{RRM}	Reverse recovery current		-	17.5		A
t_{rr}	Reverse recovery time	I_{SD} = 8.5 A, di/dt = 100 A/µs V_{DD} = 60 V, T_j = 150 °C (see *Figure 17*)	-	328		ns
Q_{rr}	Reverse recovery charge		-	2.8		µC
I_{RRM}	Reverse recovery current		-	17		A

1. Limited by maximum junction temperature
2. Pulse width limited by safe operating area
3. Pulsed: pulse duration = 300 µs, duty cycle 1.5%

2.1 Electrical characteristics (curves)

Figure 2. Safe operating area

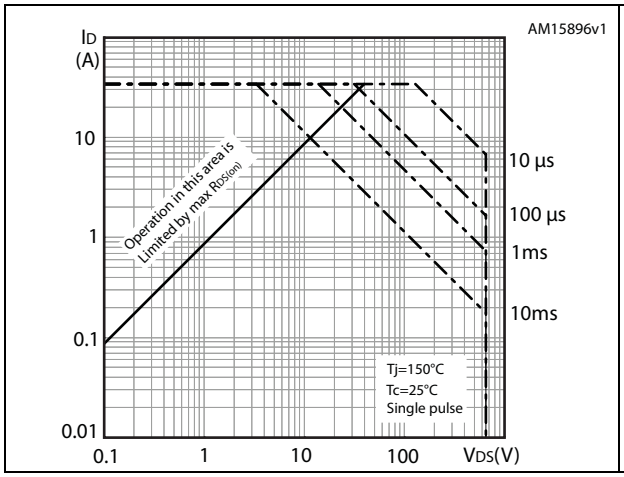


Figure 3. Thermal impedance

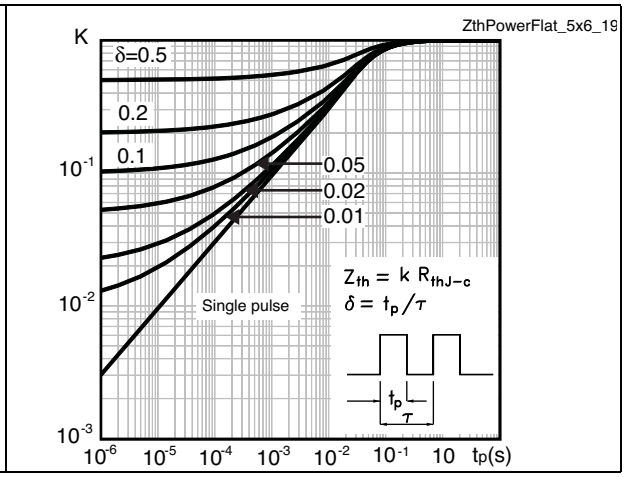


Figure 4. Output characteristics

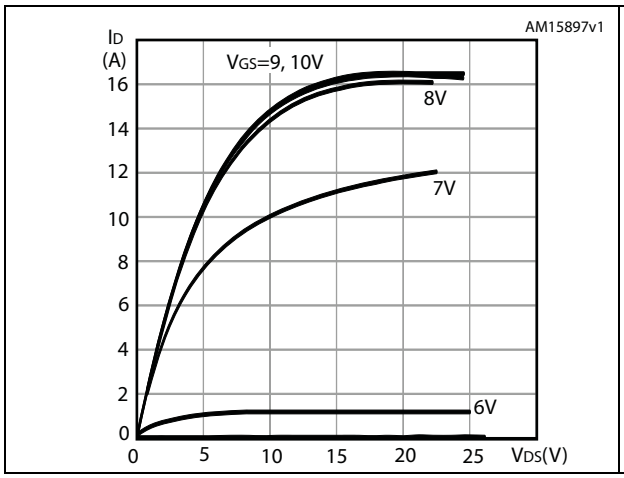


Figure 5. Transfer characteristics

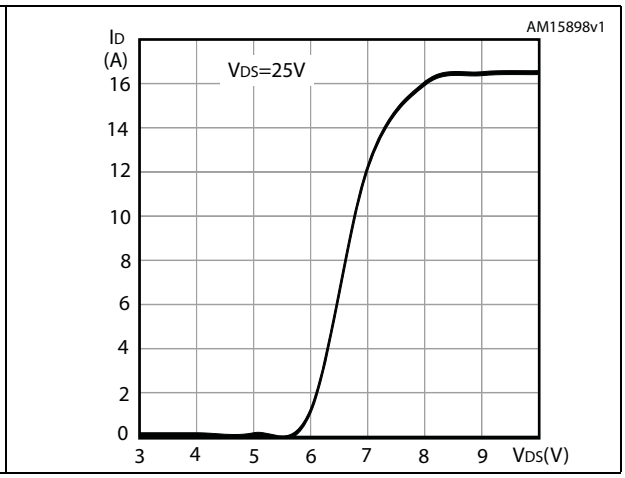


Figure 6. Static drain-source on-resistance

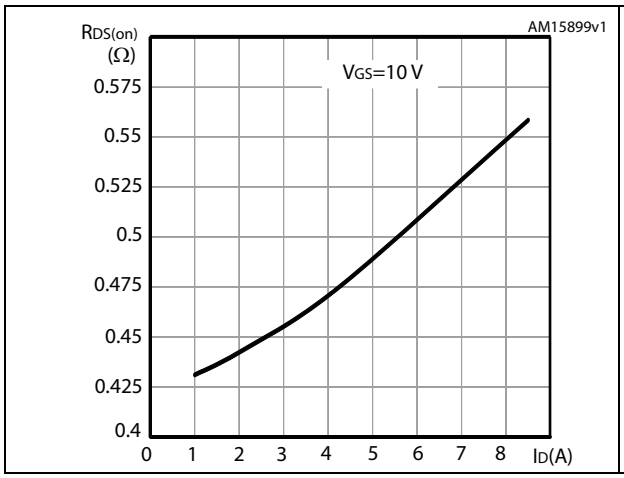


Figure 7. Gate charge vs gate-source voltage

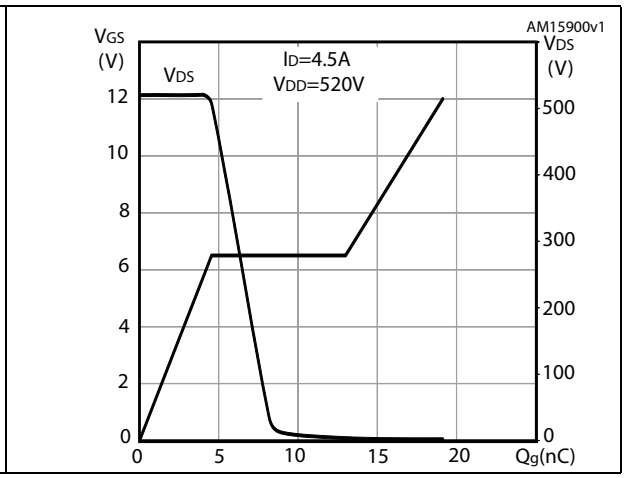


Figure 8. Capacitance variations

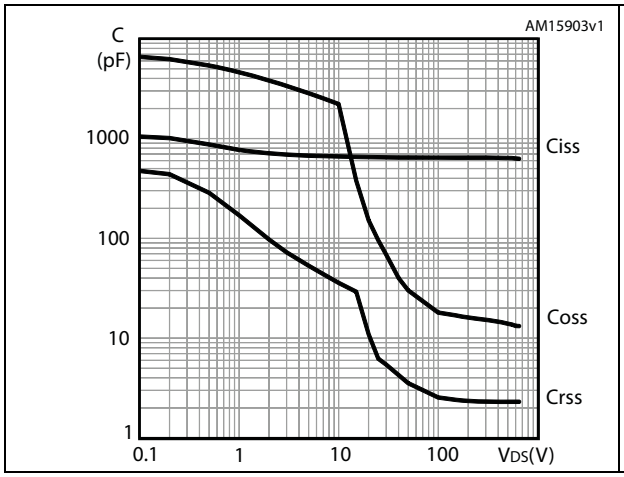


Figure 9. Output capacitance stored energy

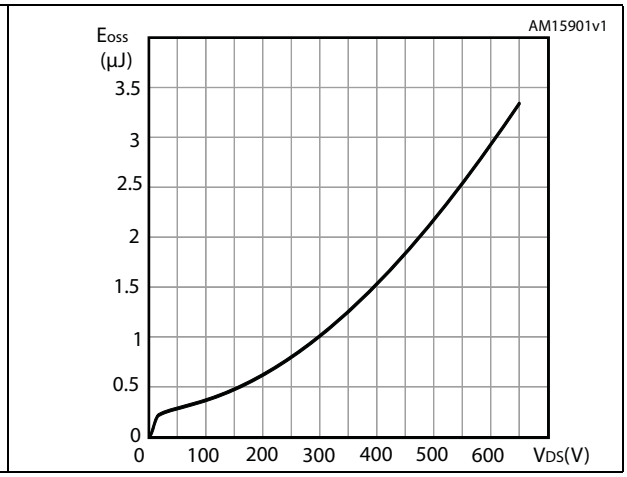


Figure 10. Normalized gate threshold voltage vs temperature

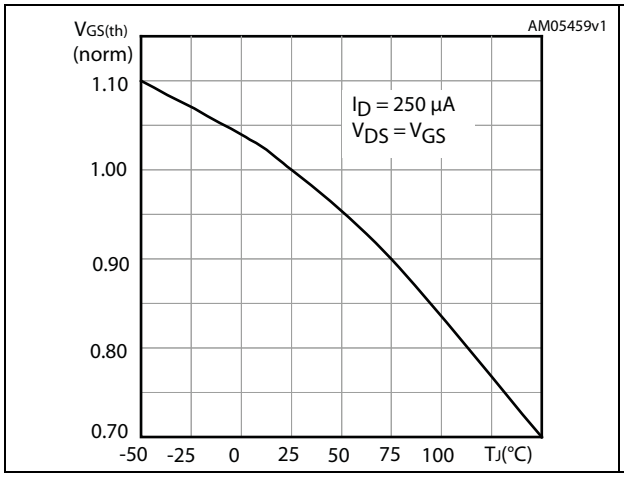


Figure 11. Normalized on-resistance vs temperature

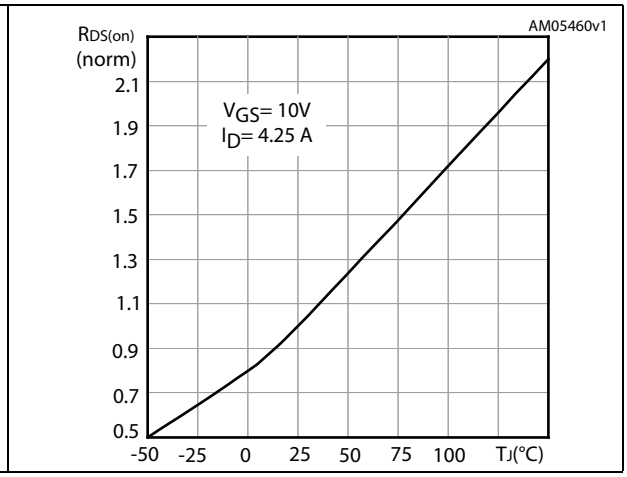


Figure 12. Source-drain diode forward characteristics

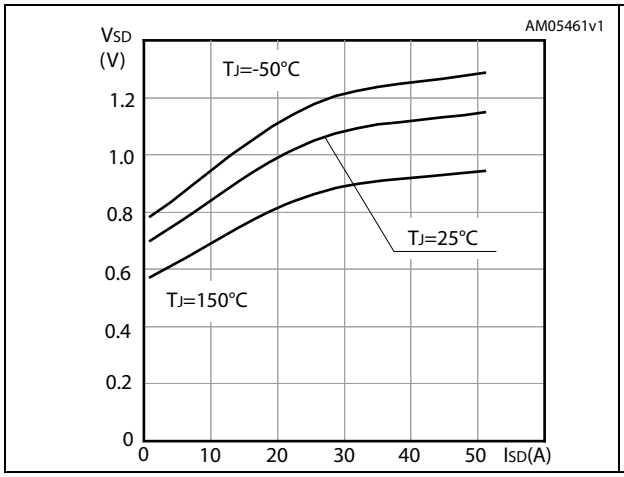


Figure 13. Normalized V_{DS} vs temperature

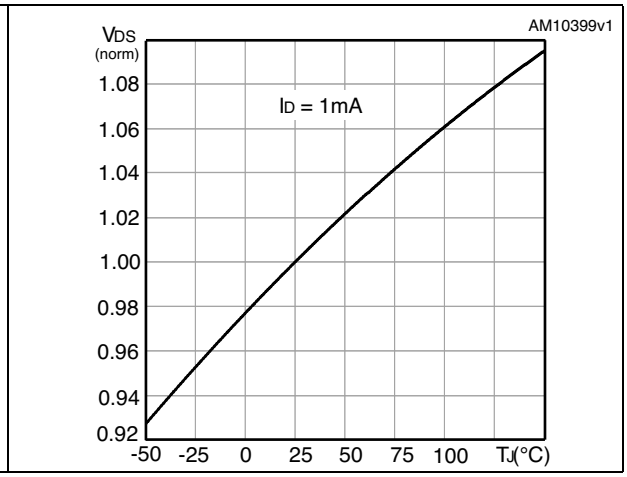
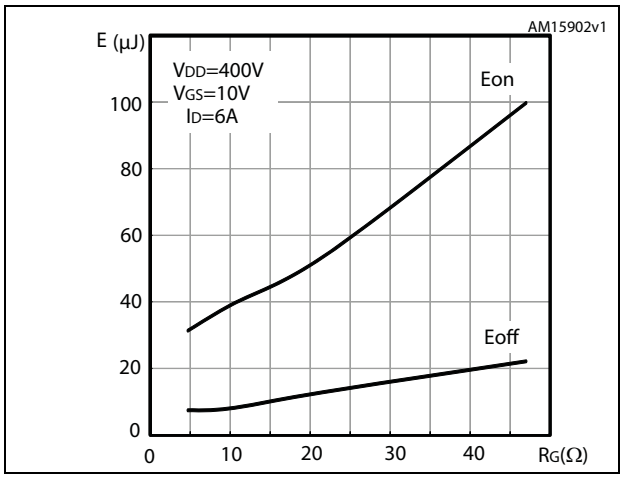


Figure 14. Switching losses vs gate resistance (1)



1. Eon including reverse recovery of a SiC diode

3 Test circuits

Figure 15. Switching times test circuit for resistive load

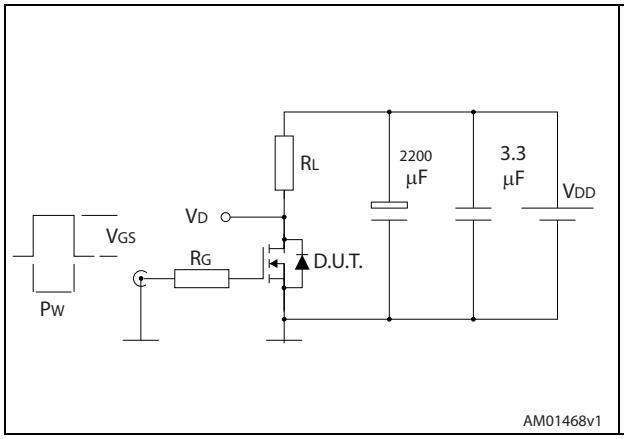


Figure 16. Gate charge test circuit

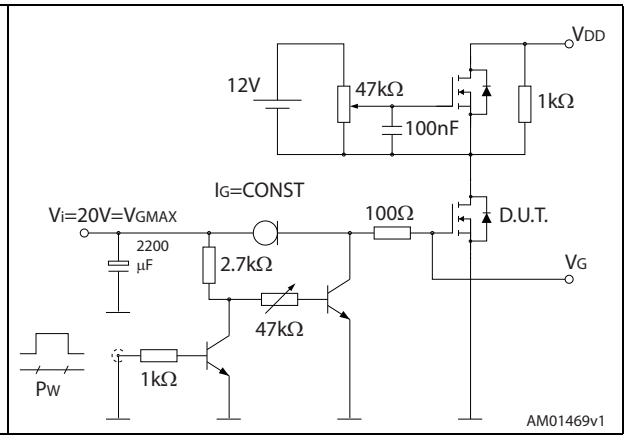


Figure 17. Test circuit for inductive load switching and diode recovery times

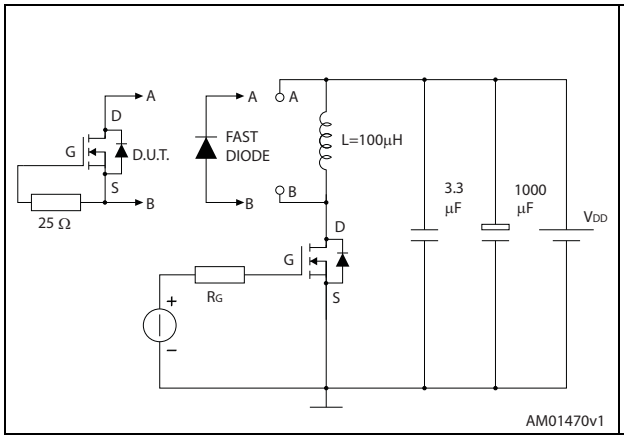


Figure 18. Unclamped inductive load test circuit

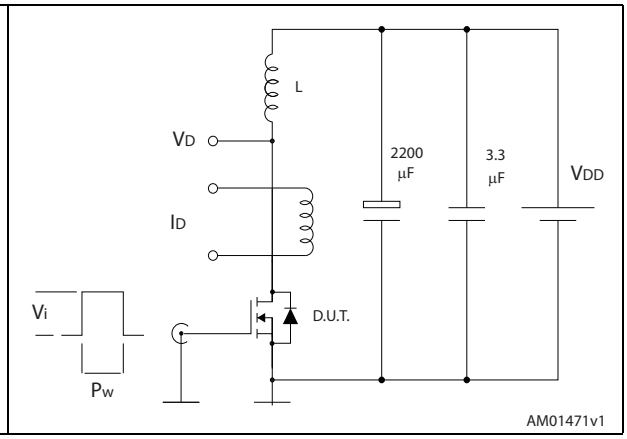


Figure 19. Unclamped inductive waveform

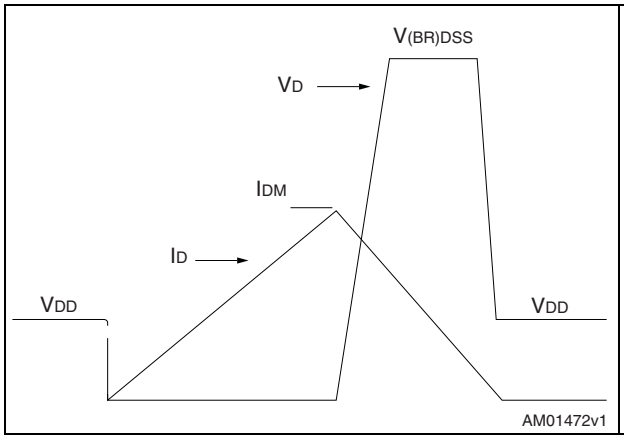
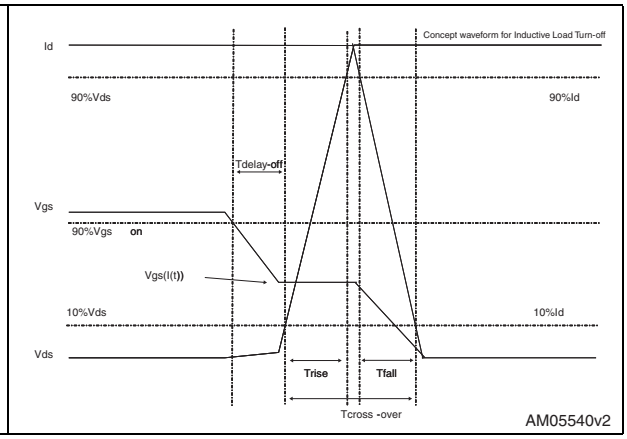


Figure 20. Switching time waveform



4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK® packages, depending on their level of environmental compliance. ECOPACK® specifications, grade definitions and product status are available at: *www.st.com*.
ECOPACK® is an ST trademark.

Table 8. PowerFLAT™ 5x6 HV mechanical data

Dim.	mm		
	Min.	Typ.	Max.
A	0.80		1.00
A1	0.02		0.05
A2		0.25	
b	0.30		0.50
D	5.00	5.20	5.40
E	5.95	6.15	6.35
D2	4.30	4.40	4.50
E2	3.10	3.20	3.30
e		1.27	
L	0.50	0.55	0.60
K	1.90	2.00	2.10

Figure 21. PowerFLAT™ 5x6 HV drawing

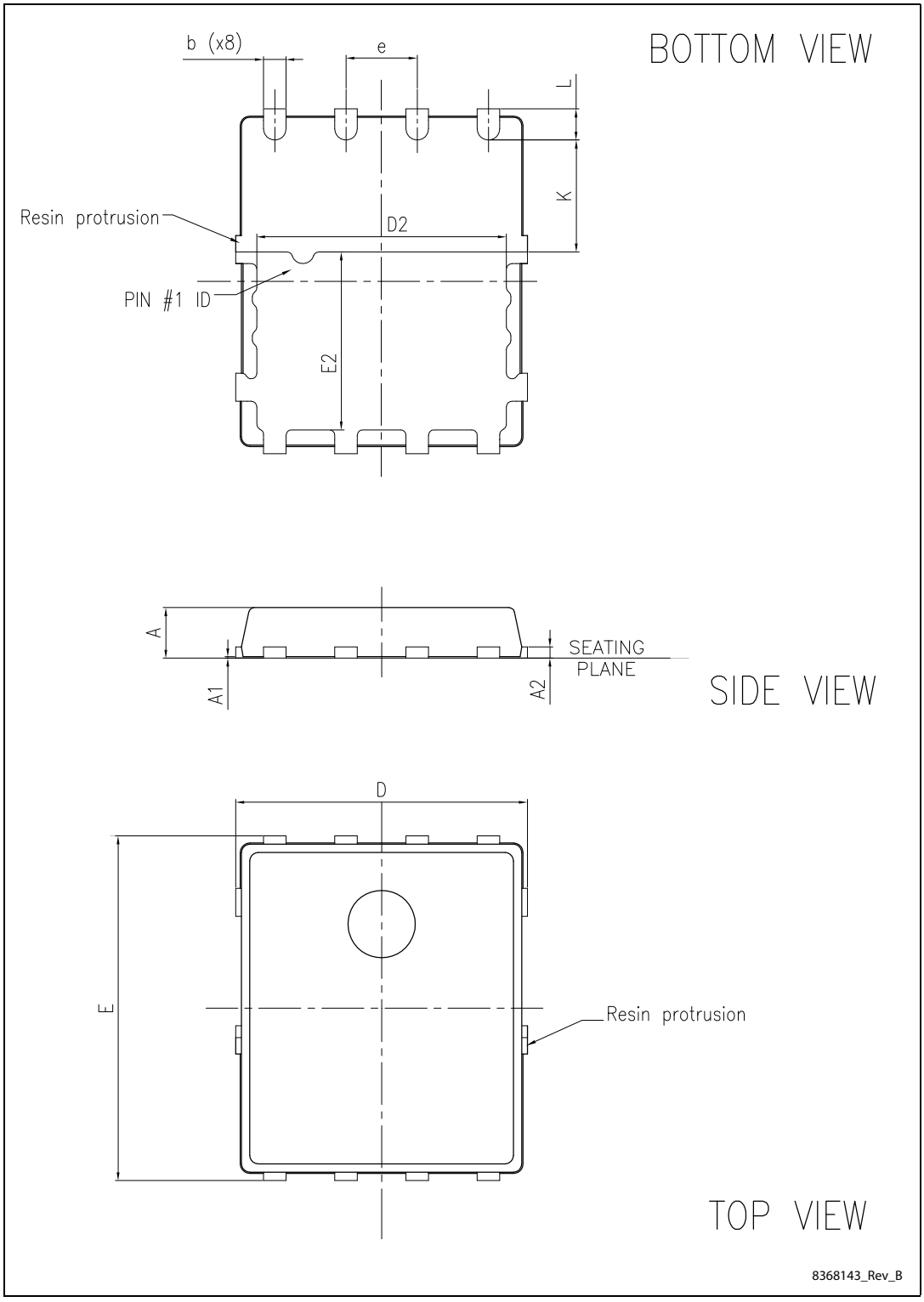
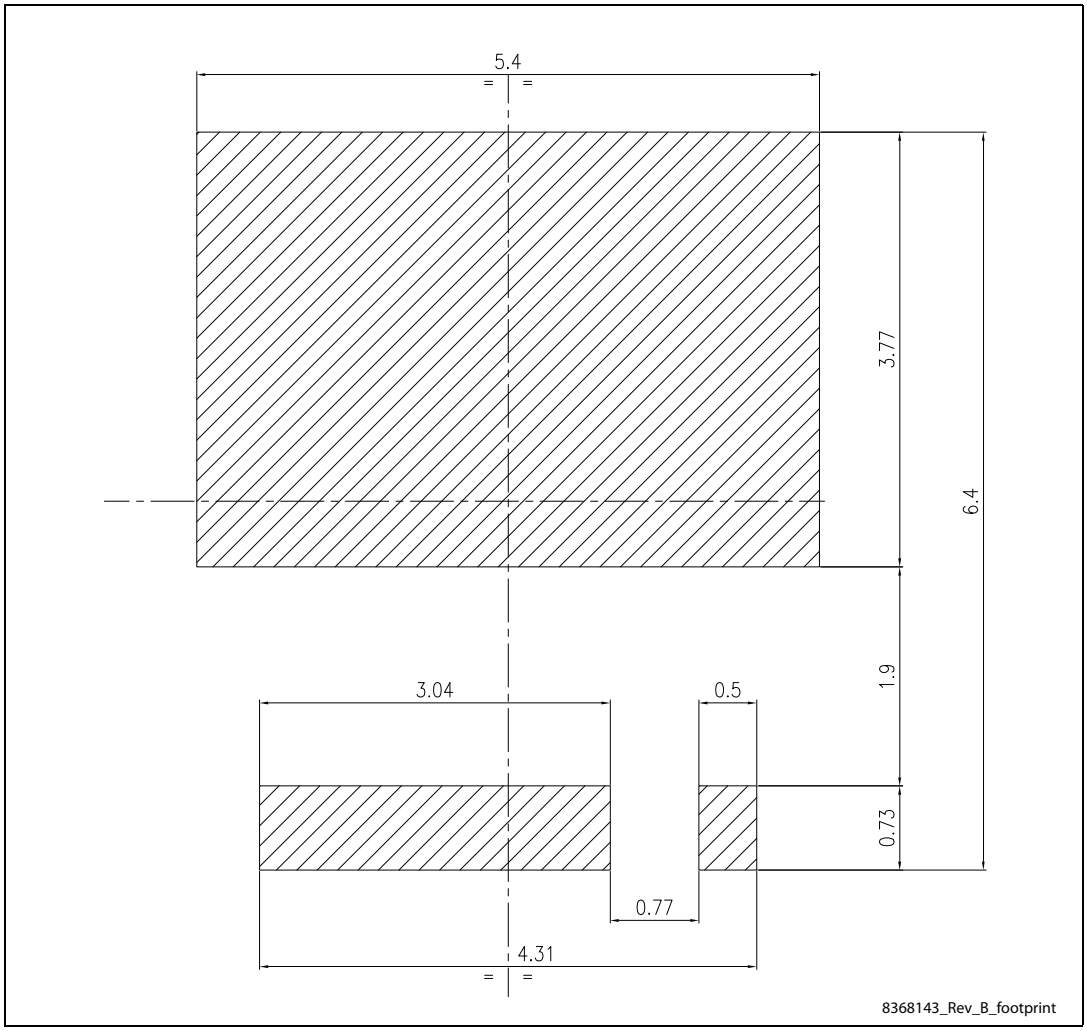
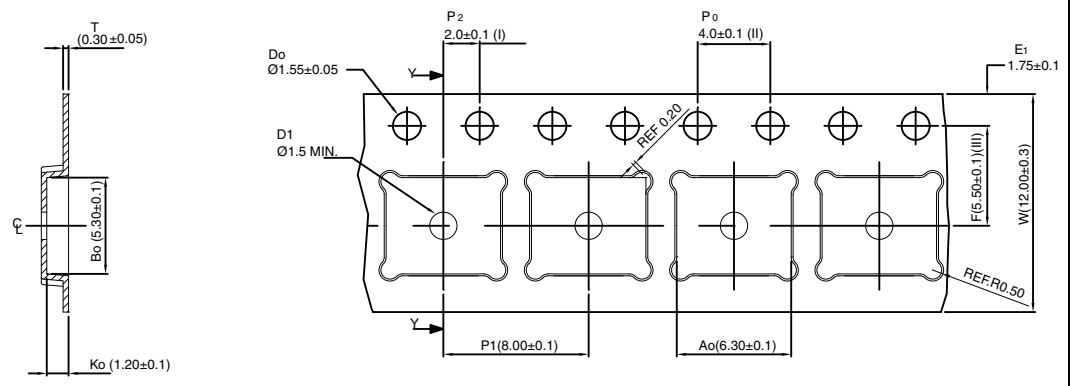


Figure 22. PowerFLAT™ 5x6 HV recommended footprint (dimensions are in mm)



5 Packaging mechanical data

Figure 23. PowerFLAT™ 5x6 tape[(a)]



(I) Measured from centerline of sprocket hole to centerline of pocket.

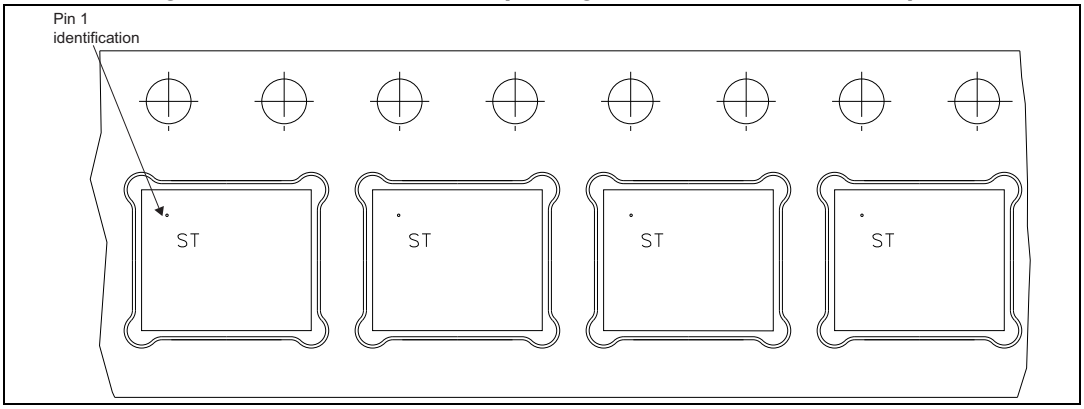
(II) Cumulative tolerance of 10 sprocket holes is ± 0.20 .

(III) Measured from centerline of sprocket hole to centerline of pocket.

Base and bulk quantity 3000 pcs

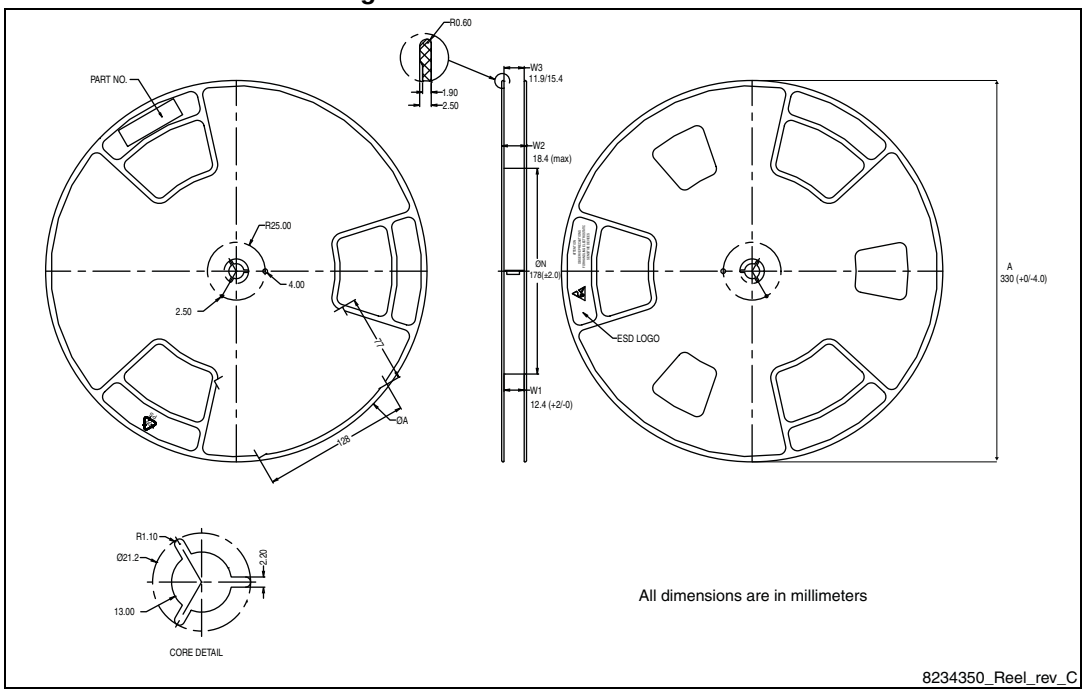
8234350_Tape_rev_C

Figure 24. PowerFLAT™ 5x6 package orientation in carrier tape.



a. All dimensions are in millimeters.

Figure 25. PowerFLAT™ 5x6 reel



6 Revision history

Table 9. Document revision history

Date	Revision	Changes
30-Apr-2010	1	First release
22-Nov-2011	2	Document status promoted from preliminary data to datasheet: – Added Section 2.1: Electrical characteristics (curves) – Added Section 5: Packaging mechanical data Minor text changes
08-Jul-2013	3	– Changed: package – Modified: I_D (at T_C=100 °C), P_{TOT} value – Deleted: I_D at T_{amb}=25 °C and 100 °C – Modified: note *1* and *3* in *Table 2*, R_G in *Table 5*, I_{SD} in *Table 7* – Changed: figures in *Section 2.1: Electrical characteristics (curves)*
17-Jul-2013	4	– Minor text changes – Modified: *Table 6: Switching times* – Updated: *Section 4: Package mechanical data*

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